

**Search Notes**

Application/Control No.

10/671,592

Examiner

Chris C. Chu

Applicant(s)/Patent under  
Reexamination

YAMADA ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	690, 691, 701, 584 and 678	8/16/2005	C.C.
361	728 & 772	8/16/2005	C.C.
174	52.1&52.4	8/16/2005	C.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
as same	as above	8/16/2005	C.C.

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	8/16/2005	C.C.
Consulted with David E. Graybill 257/584, 690, 691 & 701	2/24/2005	C.C.
Consulted with S. Clark & Roy Potter No search area	2/28/2005	C.C.
Consulted with Jerome Jackson	8/16/2005	C.C.